Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/704,898	ABI-NASSIF ET AL.	
Examiner	Art Unit	
CHUONG T. HO	2616	

SEARCHED					
Class	Subclass	Date	Examiner		
370	412	02/27/07	CH		
370	310				
370	೭32				
370	231				
370	23.5				
370	332				
370	395.72				
370	468				
370	395.4				
370	230				
370	450				
370	466				
370	452				
370	395.21				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
WEST (Text rearch,	02/27/07	CH
Class rearch)		
EAST		
STN		
IEEE	1	
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